

<b>Notice of References Cited</b>	Application/Control No. 10/571,044		Applicant(s)/Patent Under Reexamination OKU ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,899,552	05-1999	Yokoyama et al.	362/619
*	B	US-6,152,570	11-2000	Yokoyama, Kazuaki	362/613
*	C	US-7,245,433	07-2007	Yano et al.	359/599
*	D	US-6,729,736	05-2004	Umemoto, Seiji	362/621
*	E	US-7,072,115	07-2006	Uekita et al.	359/599
*	F	US-2003/0174518	09-2003	Toshima et al.	362/558
*	G	US-6,412,969	07-2002	Torihara et al.	362/609
*	H	US-2005/0030630	02-2005	Ohnishi et al.	359/599
*	I	US-7,525,531	04-2009	Ogiwara et al.	345/103
*	J	US-6,741,307	05-2004	Matsunaga et al.	349/112
*	K	US-2004/0240070	12-2004	Suzuki et al.	359/599
*	L	US-2002/0005924	01-2002	Kimura, Yoshihisa	349/112
*	M	US-2002/0172810	11-2002	Murata et al.	428/204

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

#### NON-PATENT DOCUMENTS

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,596,375	07-2003	Murata et al.	428/144
*	B	US-6,480,249	11-2002	Iwata et al.	349/112
*	C	US-2002/0102367	08-2002	Shimodaira et al.	428/1.6
*	D	US-6,936,313	08-2005	Sakata et al.	428/1.53
*	E	US-2002/0068134	06-2002	Yagi et al.	428/1.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	A	US-			
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	X				

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